

MICRO-331

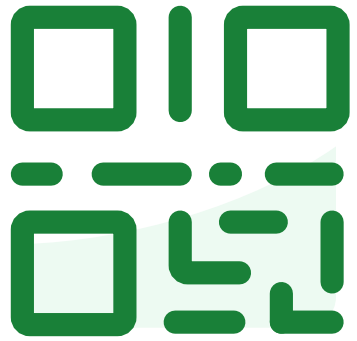
Microfabrication technologies

Lecture 2
Yujia Zhang

2025 edition

- 1st hour:
 - Feedback of the SLT_1 (8')
 - Feedback and update on the AI tutor (2')
 - Recapitulation: MEMS (10')
 - Recapitulation: Cleanroom (10')
 - Process flow (10')
 - Q&A (5')

- 2nd hour:
 - Chemical vapor deposition (CVD) (40')
 - Q&A (5')



**Join at slido.com
#3529949**

Yujia Zhang

- What was your experience when **preparing** for the first SLT?

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**What was your experience when
preparing for the first SLT?**

- What was your experience **during** the first SLT?

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What was your experience **during**
the first SLT?

- What was your impression **after** the first SLT?

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What was your impression **after**
the first SLT?

- Any suggestions, comments, things to be improved?

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Audience Q&A

Any suggestions, comments, and things to be improved?

Speaker

Feedback and update on the AI tutor

- Any questions when using the AI tutor?
- Fasten seat belt: AI Tutor BOT now in 'adventurous' mode





Recapitulation: MEMS & Cleanroom

- What are MEMS?
 - Micro-Electro-Mechanical Systems
 - Microsystems
 - Microfabrication
 - Microtechnology **MICRO-331**
 - Nanotechnology
 - ...
- **Microfabrication is a manufacturing technology**
 - A way to make micro-stuff
 - Adapted from the semiconductor industry (Integrated Circuit, IC)
 - Therefore, many standard design **principles** hold
 - **With changes!**

■ IC

- Silicon doping
- Silicon oxidation
- Thin film deposition
 - (CVD/PVD)
- Photolithography
- Thin film etching
 - (dry/wet)
- ...

Nothing moves !!

■ MEMS

- Create **mechanically freestanding and movable** elements for physical **sensing** or **actuation**. For example:

- Accelerometers
- Microphones
- Bulk Acoustic Wave resonators
- Bi-morph micro-actuator

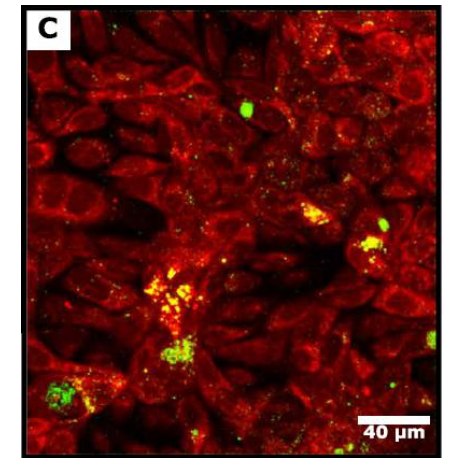
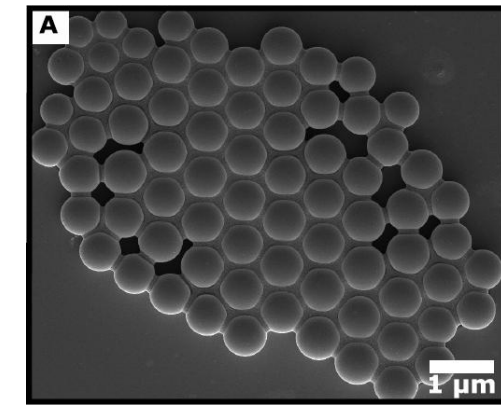
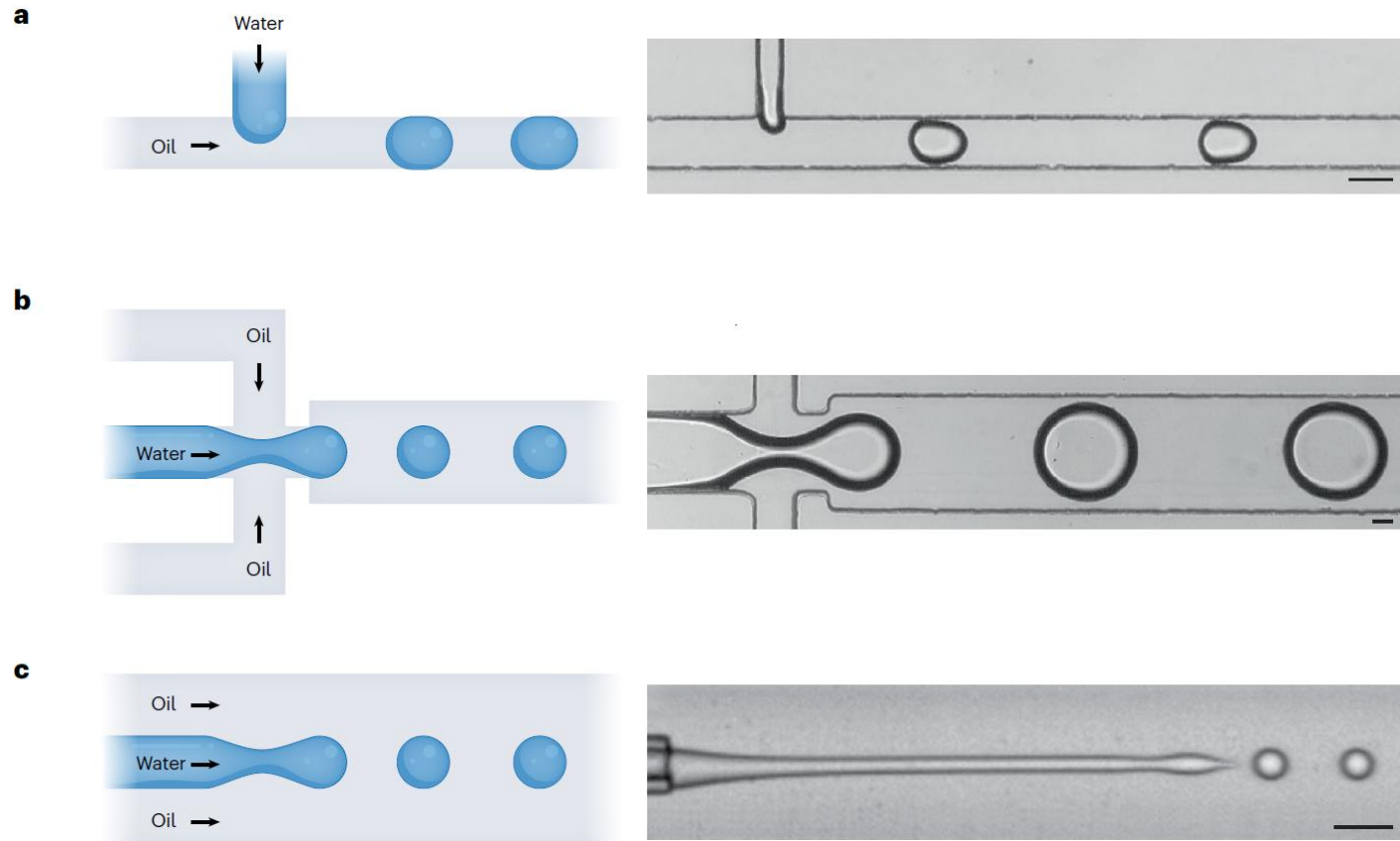
See MOOC:

Successful MEMS + Bimorph case study

*AI: The key difference is that Integrated Circuits (ICs) are purely electronic, processing and controlling signals, while Micro-Electro-Mechanical Systems (MEMS) combine electronic and mechanical components to sense or actuate physical quantities like pressure or motion. **ICs are like the "brain," handling data, whereas MEMS act as the "eyes" and "arms," interacting with the physical world.***

However, definitions can evolve

- Now, many 'MEMS' have no 'E' or 'M'
- For example:
 - Microfluidic systems



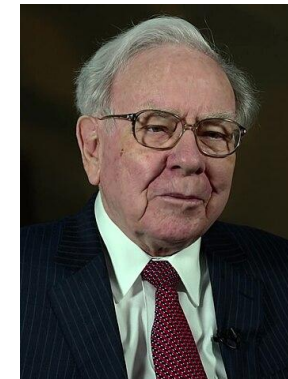


- 8.01 **Quantum Devices and Systems** with MEMS/NEMS
- 8.02 Internet of Things (IoT) with MEMS/NEMS
- 8.03 Nonlinear Dynamics in MEMS/NEMS
- 8.04 New Computing Devices and Systems with MEMS/NEMS
- 8.05 **Machine Learning (ML) & Artificial Intelligence (AI)-Enhanced** MEMS/NEMS Design, Manufacturing, and Applications
- 8.06 MEMS/NEMS for the **Hardware of AI, Virtual Reality, Augmented Reality**
- 8.07 MEMS/NEMS for Hardware Security (e.g., Electronic Circuits, Systems)
- 8.08 MEMS/NEMS for Advancing Scientific Instrumentation and Metrology

- Science:
 - Approaches to prepare tiny materials for testing (e.g., nanofluidic channels)
 - Interesting effects at the micro-/nano-scale
 - Unique application scenarios, i.e., minimally invasive implants, ultra-low-power sensors, etc
 - ...

- Commercialisation:
 - Huge markets: automobile industry, medical implants...
 - **Smaller** components mean a **higher integration** level, e.g., a smartphone
 - **Scale-up production** means **cheaper** than alternatives, e.g., glucose monitors

 - Tbh, it's challenging to design and more challenging to fabricate (batch-to-batch variation)
 - low successful rate → high cost
 - Unforeseen issues related to system **connection** (to other components) and **packaging**
 - **Cleanroom** → very high cost
 - But if it works, then you have an **Economic Moat**



- Why do we need a cleanroom?

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Why do we need a cleanroom?

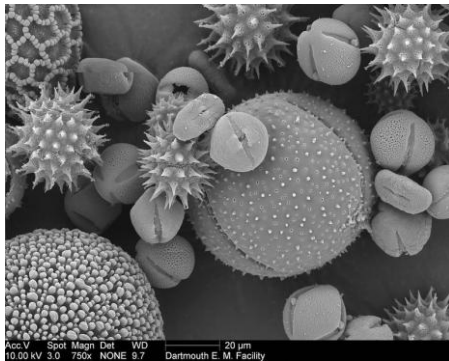
Speaker



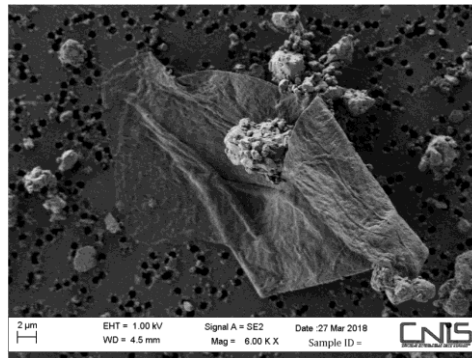
What is the ISO class of the CMi at EPFL?

Speaker

- ISO 14644 is the international standard used to design, construct, validate and operate a **cleanroom**.
- ISO 14644-1:2015 specifies the classification of air cleanliness in terms of concentration of **airborne particles** in cleanrooms and clean controlled environments.



Pollen



Skin dust

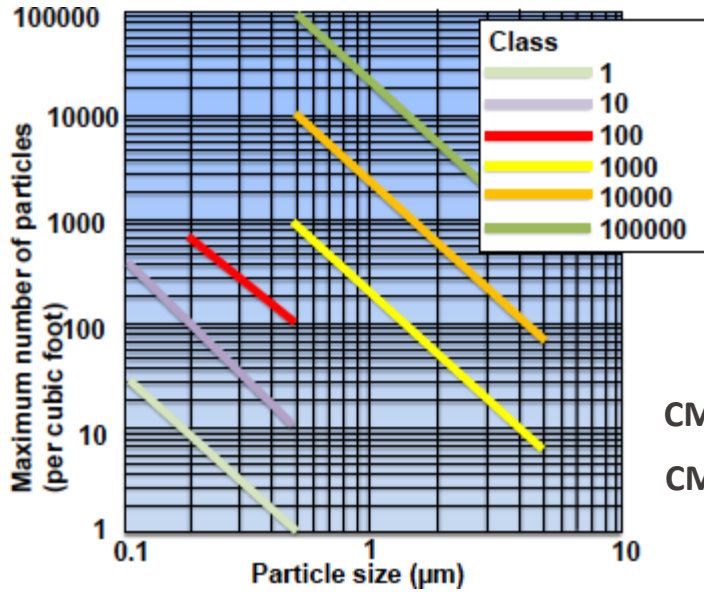


Cement dust

Unwanted ions and chemicals, etc



- ISO class 1: 10 particles per m³ (particles > 0.1µm)
- ISO class 5: 100,000 particles per m³ (particles > 0.1µm)



CMi BM -1
CMi BM +1

Concentration max allowed of particles (particles/m³ of air)
Particles sizes equal or superior to that given below

(0.5µm particles/ft³ of air)

Class ISO	0.1 µm	0.2 µm	0.3 µm	0.5 µm	1 µm	5 µm	Class US FS209
ISO 1	10	2	0	0	0	0	
ISO 2	100	24	10	4	0	0	
ISO 3	1 000	237	102	35	8	0	1
ISO 4	10 000	2 370	1 020	352	83	0	10
ISO 5	100 000	23 700	10 200	3 520	832	29	100
ISO 6	1 000 000	237 000	102 000	35 200	8 320	293	1 000
ISO 7	∞	∞	∞	352 000	83 200	2 930	10 000
ISO 8	∞	∞	∞	3 520 000	832 000	29 300	100 000
ISO 9	∞	∞	∞	35 200 000	8 320 000	293 000	

Standard ISO 14644-1

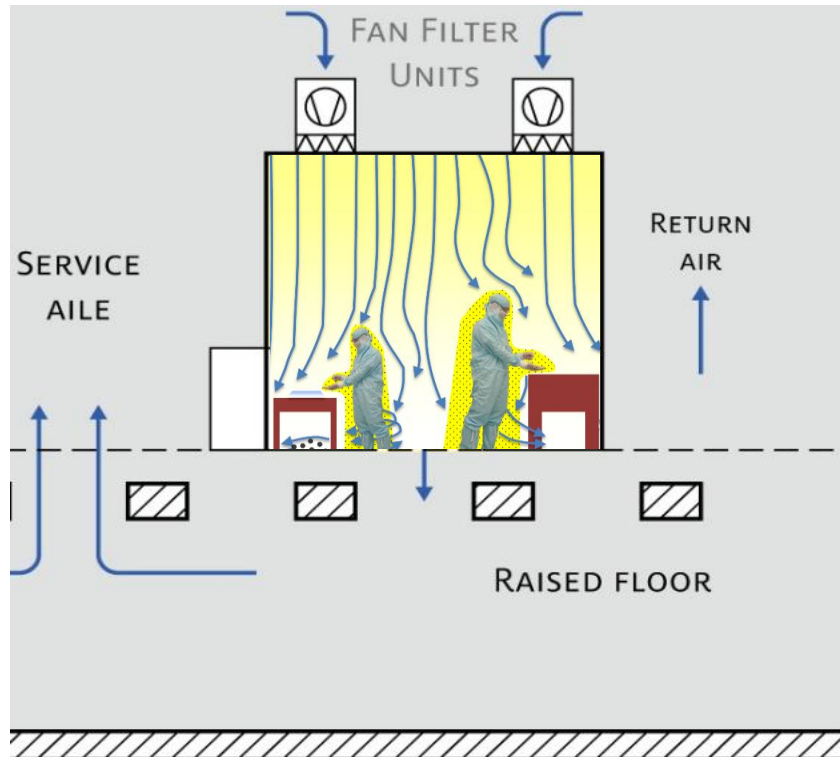
- Device processing yield
- Device performance
- Device reliability

*See MOOC:
Cleanroom basics and CMi overview*

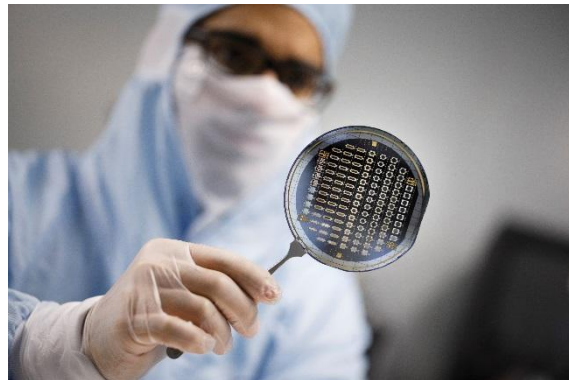
...

■ Air filtration

- Continuous air supply through filters. Laminar flow top to bottom.
 - HEPA (High Efficiency Particulate Air) or ULPA (Ultra-low Penetration Air) filters
 - Constant air flow: 20 to 600 air changes per hour
 - **Positive** air pressure

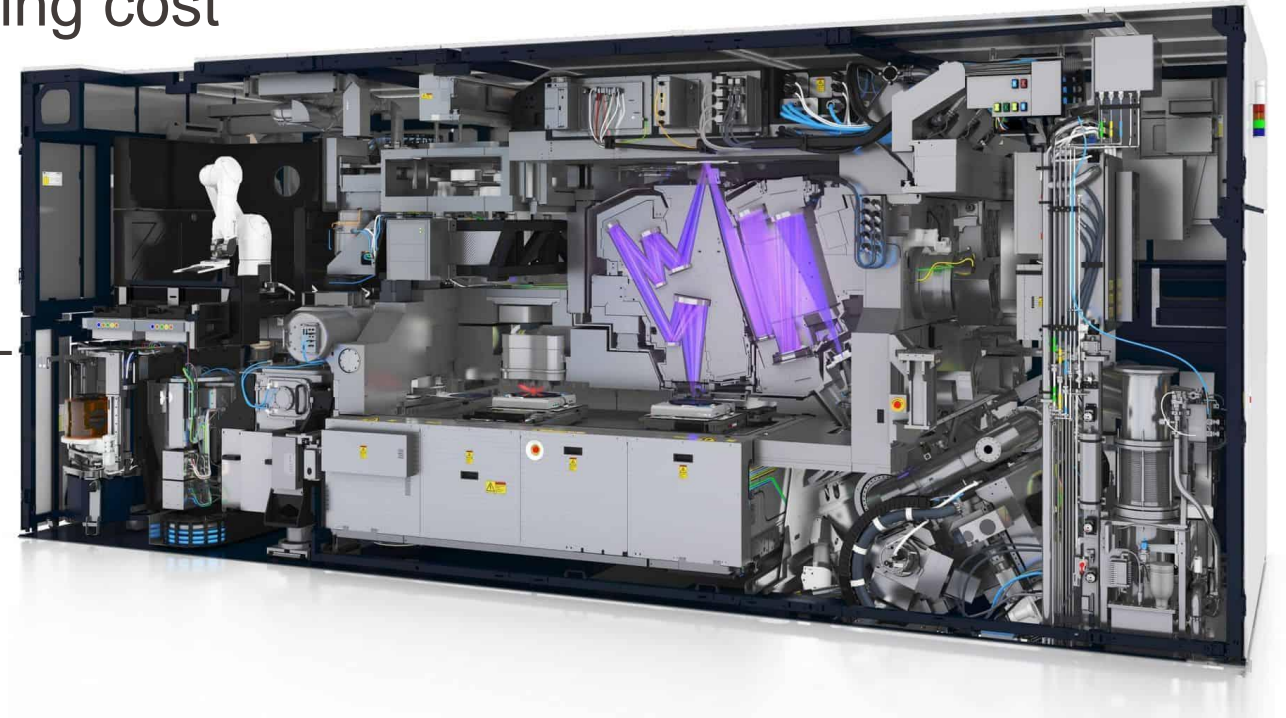


- **Temperature and humidity control**
 - 20 – 24°C (stability of photolithography)
 - 40 – 60% RH
- **Tight control of media:**
 - Water (minerals, particles, dissolved ions)
 - Chemicals (purity, mobile ions)
 - Gas (purity, water vapour content, particulates)
- **Special cloth, compatible tools, and lint-free paper, etc**
 - Surface cleanliness
 - Equipment and tools designed to minimise particle shedding
 - Stainless steel, coated plastics, lint-free cloths



- Huge capital investment and running cost

EUV Machines
~\$400 Million
Image from ASML



- **High Carbon Footprint**
EPFL's Carbon Footprint



Night View © EPFL Jamani Caillet

Please visit

<https://www.epfl.ch/about/sustainability/strategy/carbon-footprint/>
to know more



Process flow

- A process flow is like following a recipe: you combine the right ingredients in the right order and under the right conditions, building step by step—just like making a pizza.
- If you can design process flows in micro-/nanofab, you'll be in high demand in both research and industry, or even in *Michelin-starred restaurants* (e.g., *molecular gastronomy*).

See MOOC:
Bimorph case study
for an exemplary process flow



- **Vocabulary:** common techniques, e.g., thin-film depositions by CVD/PVD, lithography, etching, etc.
 - *There are huge lists of things that you can and can't do in microfab*
- **Grammar:** detailed sequence of steps and techniques
 - *There are limits on how you can combine steps together to form a process*
- **Fluency:** only practice will make you fluent!
 - *An experienced microfabricator knows most of these capabilities and limits from long experience*
- **Our goal:** teach enough vocabulary and grammar to get you started.
 - Today starts with vocabulary CVD

- A process flow example from BION

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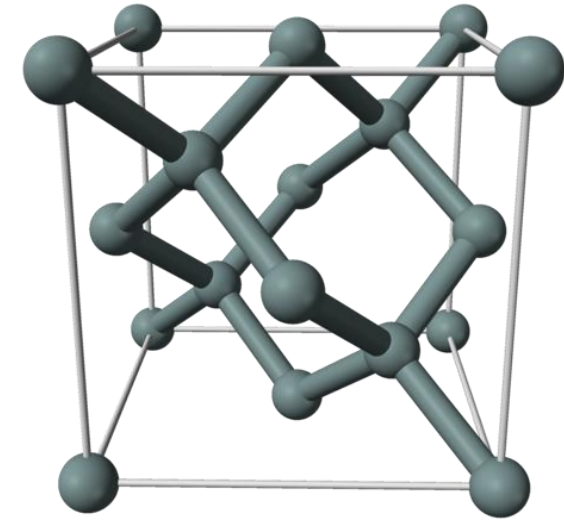
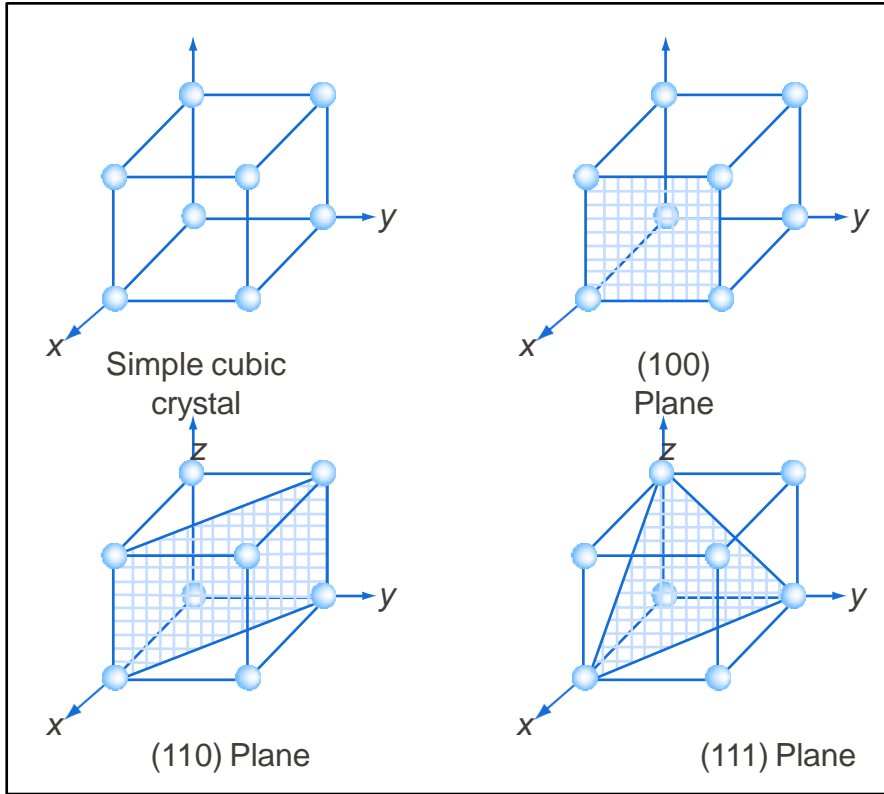




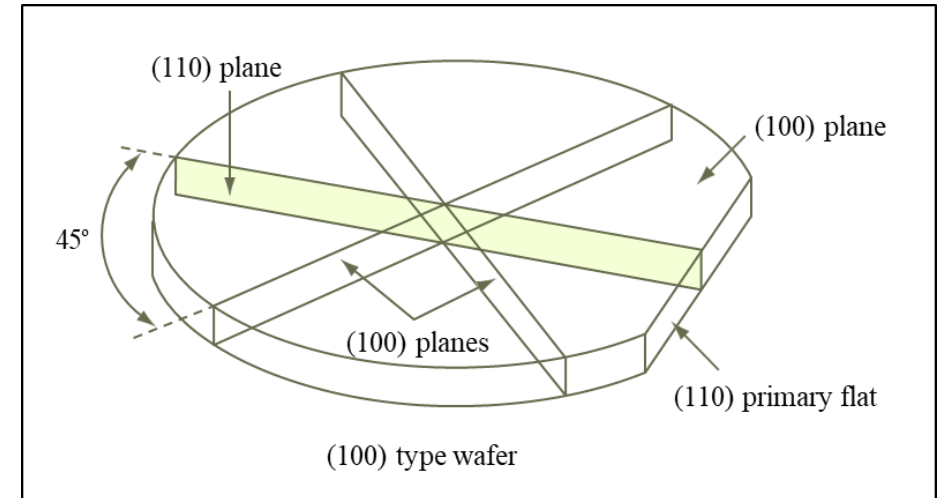
Chemical Vapour Deposition (CVD)

- **Chemical reaction** is involved
- Use of **gaseous** phase results in conformal **deposition** on substrate with arbitrary texture
- The goal is to create thin (or thick) films on the substrate (e.g., Si)
- Many techniques to choose from, so we should consider:
 - Quality of resulting films (electrical properties, etch selectivity, defects, residual stress, etc)
 - Conformality
 - Deposition rate
 - Cost
- CVD
 - Reactants are transported to the substrate, a chemical reaction occurs, and the products deposit on the substrate to form the desired film
- Physical techniques (Lecture 3)
 - Material is removed from a source, carried to the substrate, and dropped there

- Silicon Wafers
 - Silicon is a diamond-structure cubic crystal



Diamond cubic crystal structure of a silicon unit cell



Wafer orientation

We will revisit this in Etching

- Si wafers with embedded layers, such as silicon-on-insulator (SOI) wafers
 - Initial purpose: build IC's on device layer, and buried oxide minimizes stray capacitance to substrate



- Silicon Carbide (SiC) wafers, wide bandgap semiconductor, use in electronic applications under extreme conditions
- Quartz (ordered atomic structure) / Glass (cheap, high impurity content)
 - Inexpensive base for soft lithography
 - Transparent for optical access
 - Can be very strongly attached to silicon wafers via anodic bonding
- Compound semiconductors (III-V's, II-VI's)
 - Optical applications
- Sapphire
 - Strong, wear resistant, transparent, insulating substrate
 - Expensive, hard to etch

- Doping is the introduction of a controlled amount of impurities to change the conductivity type and degree of a semiconductor
- In silicon, boron is a p-type dopant (creating holes), while phosphorus, arsenic, and antimony are n-type dopants (creating conduction electrons)
- Some doping incorporated in the initial silicon melt
- All modern thin-film doping is done with ion implantation
 - A high-voltage accelerator is used to shoot ions at the wafer
 - The depth of the implant dose depends on energy
 - Activation anneal after implantation allows dopants to reach proper positions in the crystal (diffusion)
- Doping doesn't add a new thin film, but it modifies the properties of a thin film at the surface of existing material

You may learn more details in courses related to Semiconductor Physics and Devices

Taxonomy of deposition techniques

- *Thermal Oxidation*
- Classification of CVD by pressure
 - Atmospheric pressure CVD (APCVD)
 - Sub-atmospheric pressure CVD (SACVD)
 - Low-pressure CVD (LPCVD)
 - Ultrahigh vacuum CVD (UHV/CVD)
- Classification of CVD by reactor type (*not very often*)
- Other CVD
 - Plasma-enhanced CVD (PECVD)
 - Metal-organic CVD (MOCVD)
 - Atomic layer CVD (ALCVD or ALD)
- Epitaxy
- Electrodeposition (Electroplating)

See MOOC:

Overview of CVD techniques

*Not mentioned in MOOC
but very useful!*

- Silicon transforms into silicon dioxide (SiO_2), also known as silica
- How it works:
 - Oxygen diffuses through oxide to Si/oxide interface (rate determination)
 - Diffusion limits practical oxide thickness to $< 2 \mu\text{m}$
 - $\text{Si} + \text{O}_2$ at high temperature $\rightarrow \text{SiO}_2$
 - **Some Si is consumed, which makes it not truly a deposition!**

- Dry oxidation (O_2) $\text{Si (s)} + \text{O}_2 \text{ (g)} \Rightarrow \text{SiO}_2 \text{ (s)}$
 - Slow oxidation rate, smaller maximum thickness, higher quality

- Wet oxidation (H_2O steam) $\text{Si (s)} + 2 \text{H}_2\text{O (g)} \Rightarrow \text{SiO}_2 \text{ (s)} + 2 \text{H}_2 \text{ (g)}$
 - Faster oxidation rate, lower quality

See MOOC:

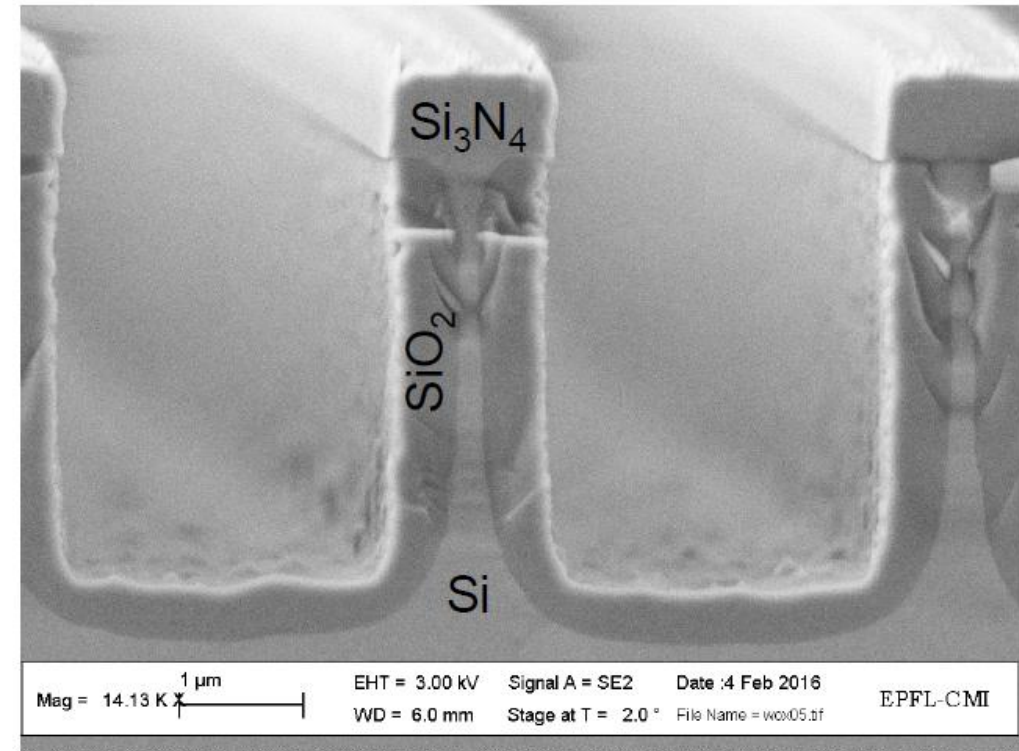
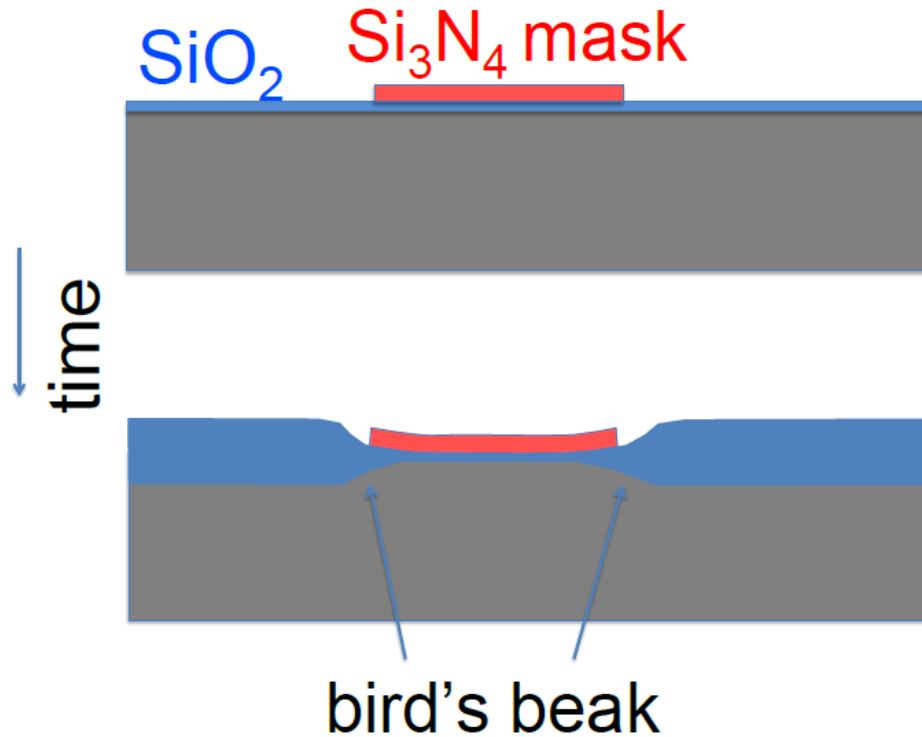
Overview of CVD techniques

Specific CVD processes

The *Deal–Grove model* describes the growth of an oxide layer on the surface of a material.

Local oxidation of silicon (LOCOS)

- Oxidation can be masked locally by an oxidation barrier, such as Si_3N_4
- Oxide undercuts the edge of a mask layer to form a 'bird's beak'
- Oxidation followed by oxide etch can also be used to sharpen silicon features.



- Oxide formation:
 - To get a thicker layer than thermal oxidation can provide
 - To create oxide on a wafer that can't withstand high temperatures
 - For example, because of metal features
 - To create oxide on top of a material that is not silicon
- For film formation in general:
 - To tailor the film properties (like film stress) by adjusting pressures, flow rates, external energy supply, ratios of different precursor gases (to adjust proportions of different materials in the final product)
 - Conformality: (more or less) even coating on all surfaces
 - To create thick films on the wafer surface

See MOOC:

Theoretical aspects of CVD

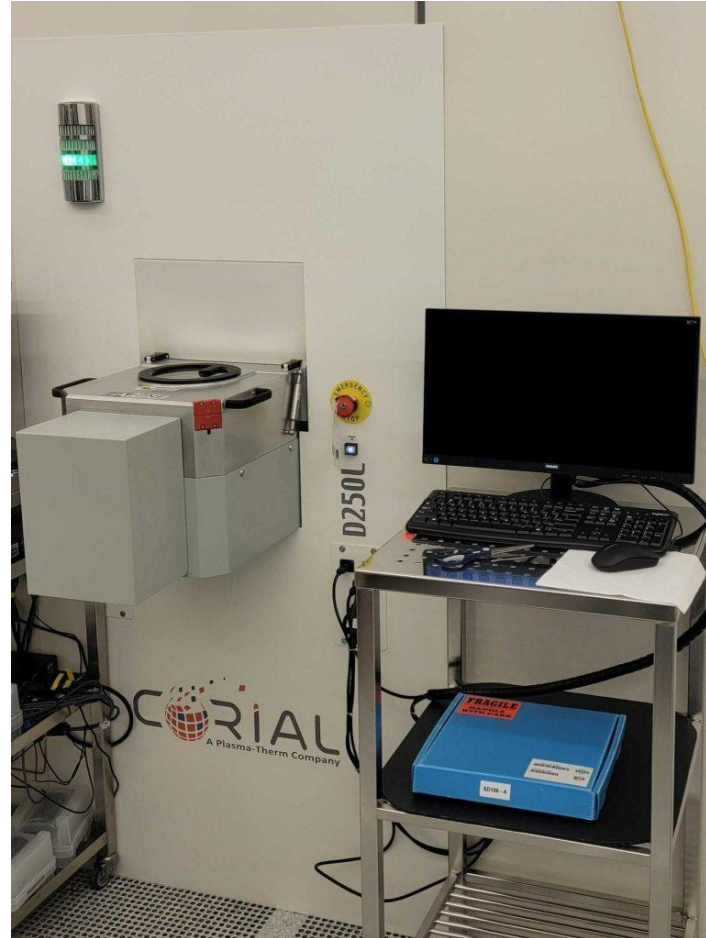
- Drawbacks
 - Films deposited at low temperature are often lower quality than high temperature versions, and have less predictable properties
 - Flammable, toxic, or corrosive source gases

- **Unlike oxidation, it does not consume substrate material**
- Gaseous reactants, often at low pressure
 - Long mean free path*; reactants reach substrate
- Reactants react and deposit products on the substrate
- Commonly deposited films: Oxide, silicon nitride, polysilicon
- How to facilitate chemical reactions:
 - High temperature, plasma, laser
 - Processing temperatures vary widely
- **CVD results depend on pressures, gas flows, and temperature**
- Film composition, uniformity, deposition rate, and electrical and mechanical characteristics can vary

▪ *The mean free path is the distance a particle will travel, on average, before experiencing a collision event.



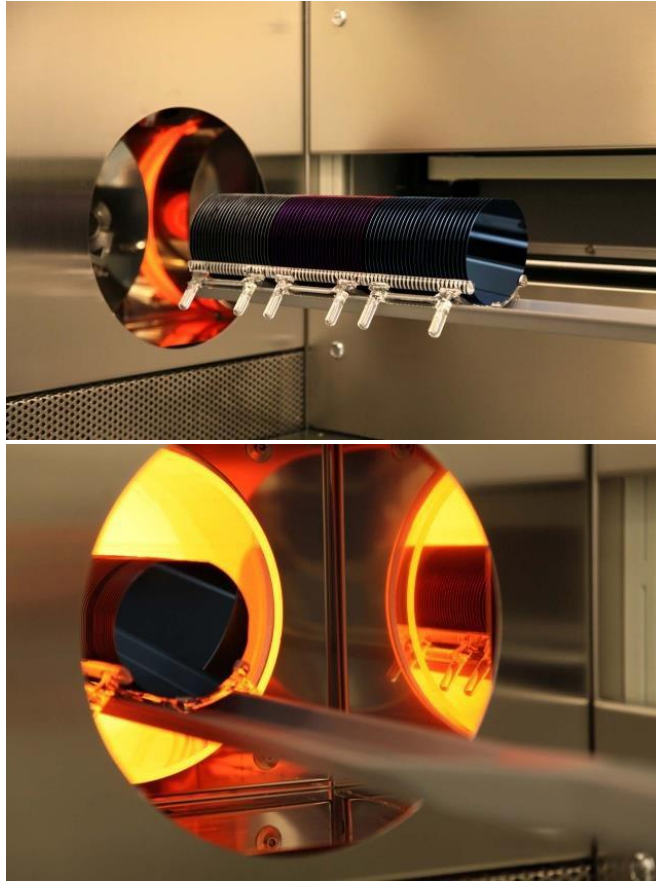
Centrotherm furnaces, 15 tubes in 4 stacks



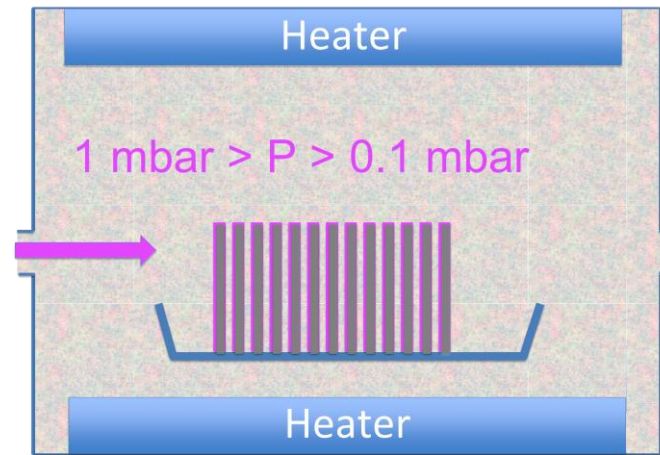
Plasma-Therm Corial D250L – PECVD



iplas CYRANNUS Microwave Plasma CVD (MPCVD) system for Diamond Growth



- A batch of Si wafers is positioned in a fused silica holder.
- After closing of entrance port, the carrier gas enters the deposition chamber under very controlled flow and temperature conditions.



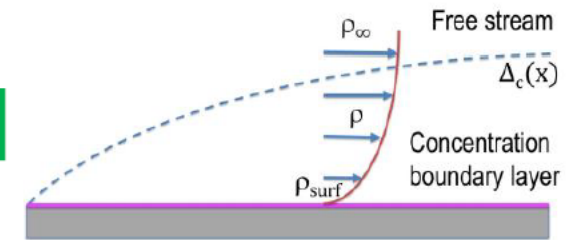
- The CVD thin film is grown on all exposed surfaces of the wafers.
- *Note: Wafers can be stacked vertically in batches due to homogeneous gas conditions, e.g., LPCVD.
- Enhanced wafer throughput.

See MOOC:
Overview of CVD techniques

- Mass transfer from gas phase to substrate
- At equilibrium, the concentration at the surface ($y=0$) is maintained at a uniform value $\rho_{surf} < \rho_{y=\infty}$ and the gas transfer rate per unit surface can be written in three dimensions as

$$\dot{N} [m^{-2}s^{-1}] = h [m s^{-1}] (\rho_{surf} - \rho_{y=\infty}) [m^{-3}]$$

with h the mass transfer coefficient



- If mass flux associated with species transfer is by **diffusion**, **Fick's law** applies at the surface

$$\dot{N} = -D \left. \frac{\partial \rho}{\partial y} \right|_{y=0} \quad h = \frac{-D \left. \frac{\partial \rho}{\partial y} \right|_{y=0}}{(\rho_{surf} - \rho_{y=\infty})}$$

See MOOC:
Theoretical aspects of CVD

- Diffusion flux of molecules through the boundary layer

$$\dot{N}_1 [m^{-2}s^{-1}] = h [m s^{-1}] (\rho_{surf} - \rho_{y=\infty}) [m^{-3}]$$

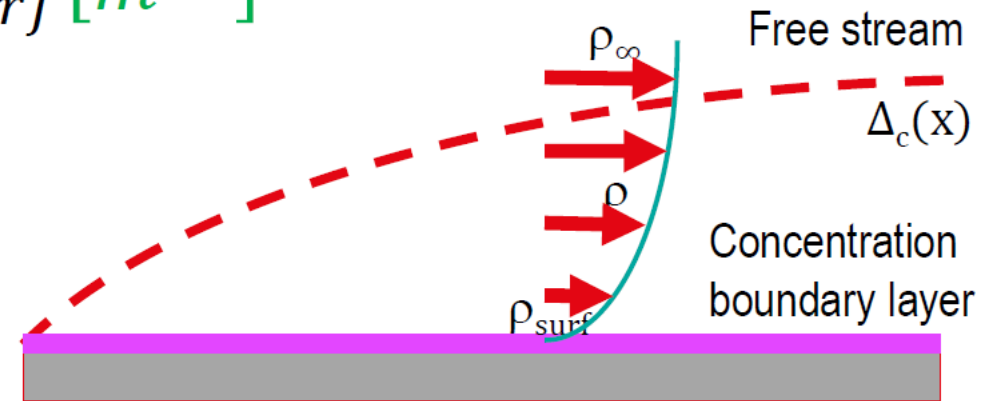
- Flux of reacted molecules consumed by the surface reaction

$$\dot{N}_2 [m^{-2}s^{-1}] = -k_{surf} [m s^{-1}] \rho_{surf} [m^{-3}]$$

with k_{surf} the surface reaction rate

- In equilibrium, $\dot{N} \equiv \dot{N}_1 = \dot{N}_2$, giving

$$\rho_{surf} = \rho_{y=\infty} \left(\frac{h + k_{surf}}{h} \right)^{-1}$$



- The film growth rate is then proportional to

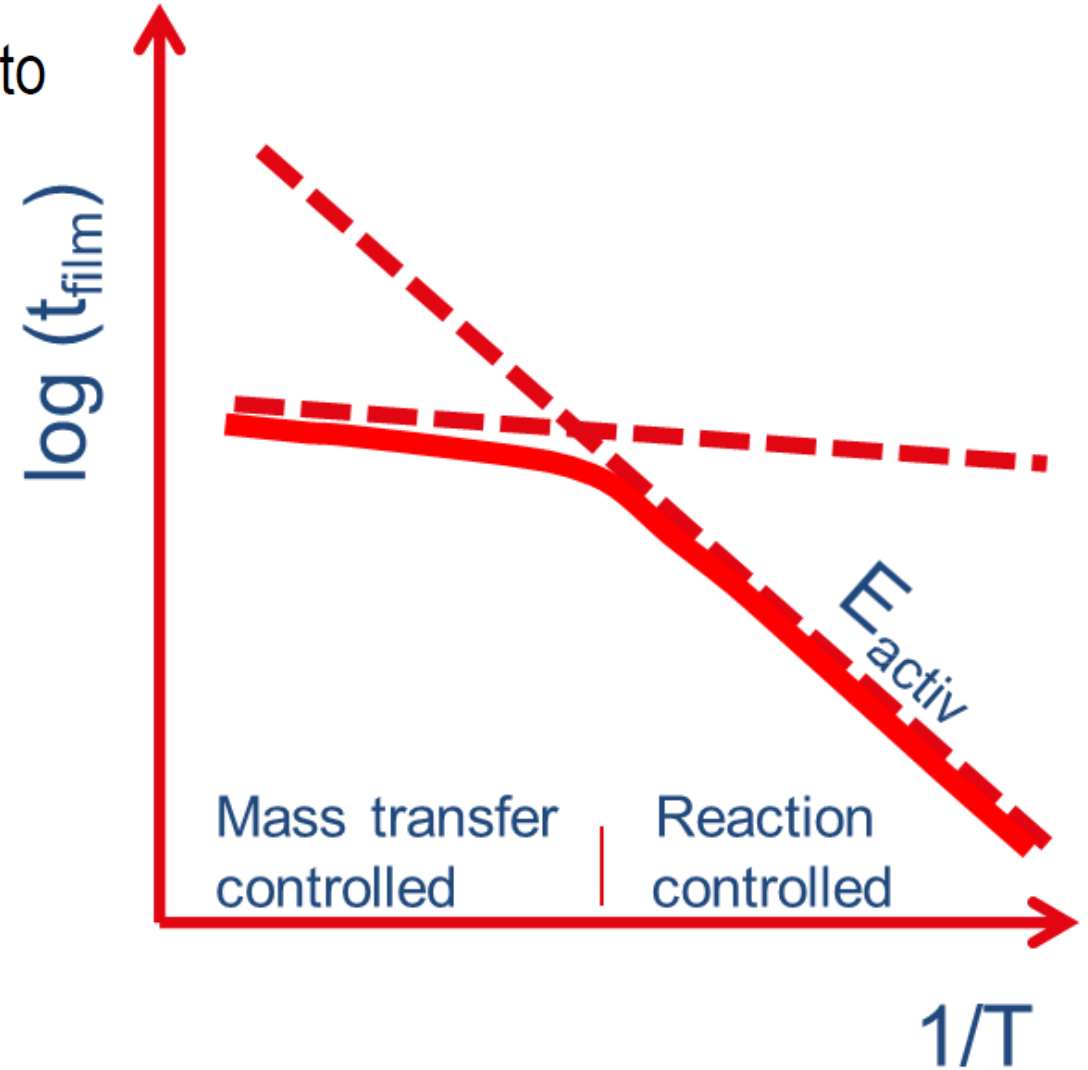
$$\dot{N} = \frac{k_{surf} h}{h + k_{surf}} \rho_{y=\infty}$$

- If $h \gg k_{surf}$, we have the surface reaction-controlled case and

$$\dot{N} = k_{surf} \rho_{y=\infty}$$

- If $h \ll k_{surf}$, we have the diffusion-controlled case and

$$\dot{N} = h \rho_{y=\infty}$$



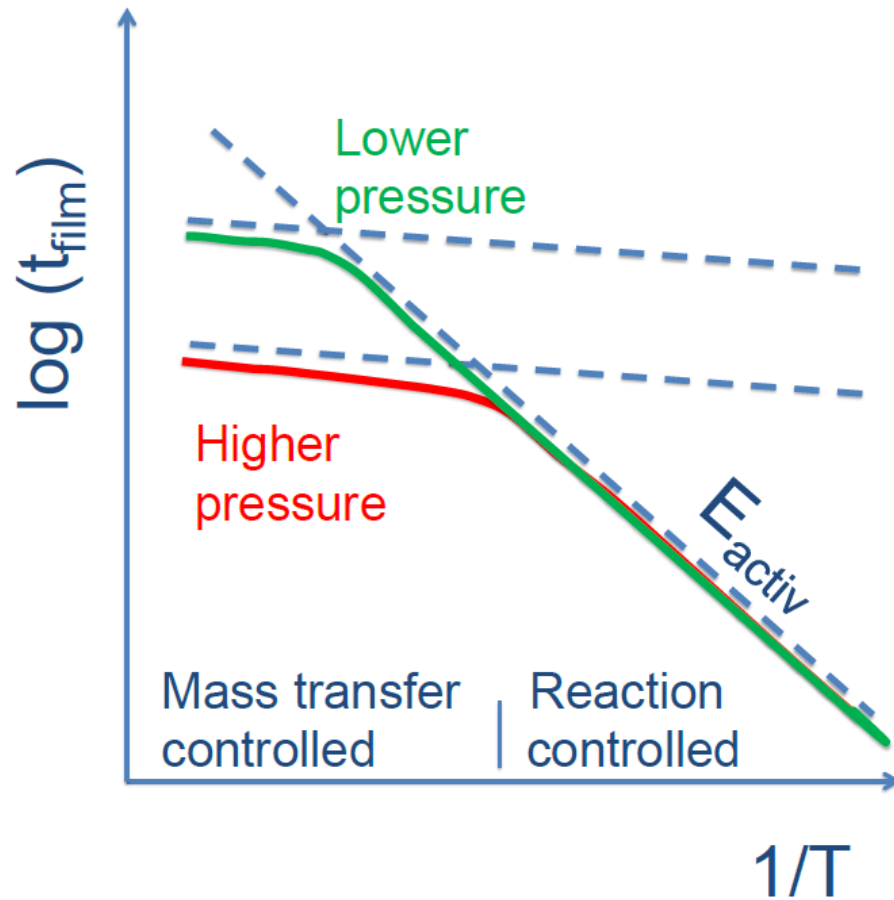
Why temperature dependent?

- Thickness of thin film grown by CVD

$$t_{film}(x) = C_{gas}(x) \cdot P_{growth} \cdot \exp\left(-\frac{E_a}{kT}\right) \sim k_{surf}$$

$C_{gas(x)}$ Concentration of the gas molecules
 P_{growth} Represents the thin film growth kinetics
 E_a Activation energy
T **Temperature**
 k Boltzmann's constant

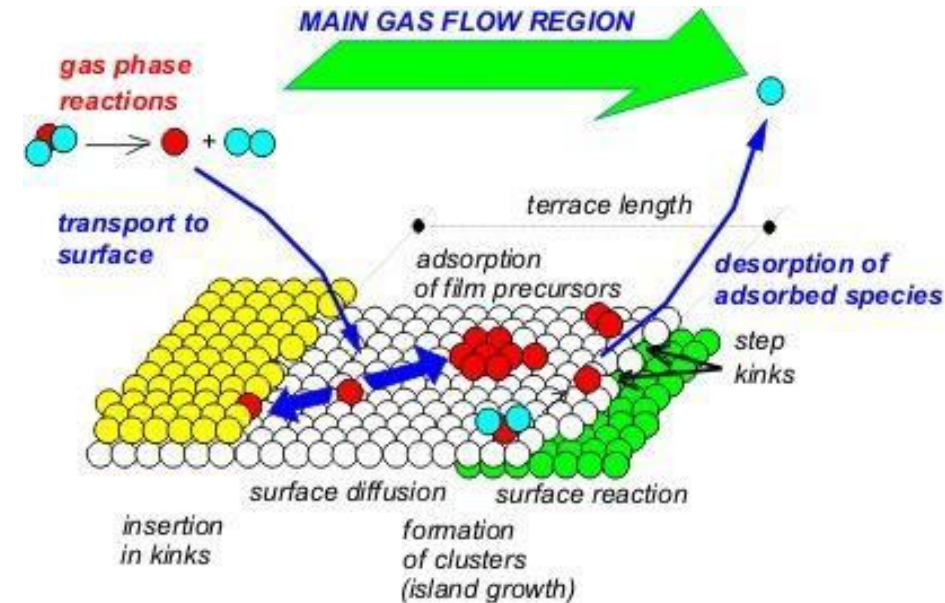
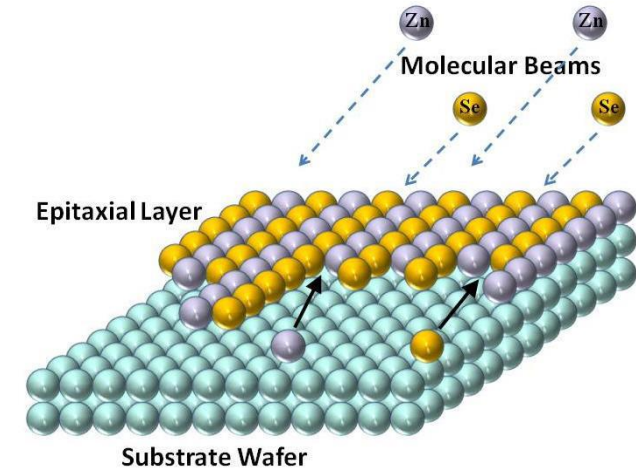
- Temperature decides whether film growth is in the reaction-limited or gas diffusion-limited regime
 - At **high** temperature, growth is in the mass transport-limited regime
 - Control of gas flow and pressure is crucial for obtaining uniform films
 - At **low** temperature, growth is in the reaction-limited regime
 - Control of local temperature is crucial for obtaining uniform films



- Lower gas pressure, higher mean free path of the gas molecules, more diffusion to the substrate
 - Sub-atmospheric pressure CVD (SACVD)
 - Low-pressure CVD (LPCVD)
 - Ultrahigh vacuum CVD (UHV/CVD)
 - PECVD
 - ...

See MOOC:
Overview of CVD techniques

- CVD deposition process in which atoms move to lattice sites, continuing the substrate's crystal structure
 - Homoepitaxy: same material, i.e., Si on Si
 - Heteroepitaxy: different materials, i.e., AlGaAs on GaAs
- How it happens
 - Slow deposition rate (enough time to find a lattice site)
 - High temperature (enough energy to move to a lattice site)
- Selective epitaxy is possible through masking
- Can grow a doped Si layer of known thickness
- Metalorganic chemical vapor deposition (MOCVD)



Absorption/desorption

☞ Physisorption:

no chemical interaction involved (van der Waals).

$$E_a \sim 100 \text{ meV/atom}$$

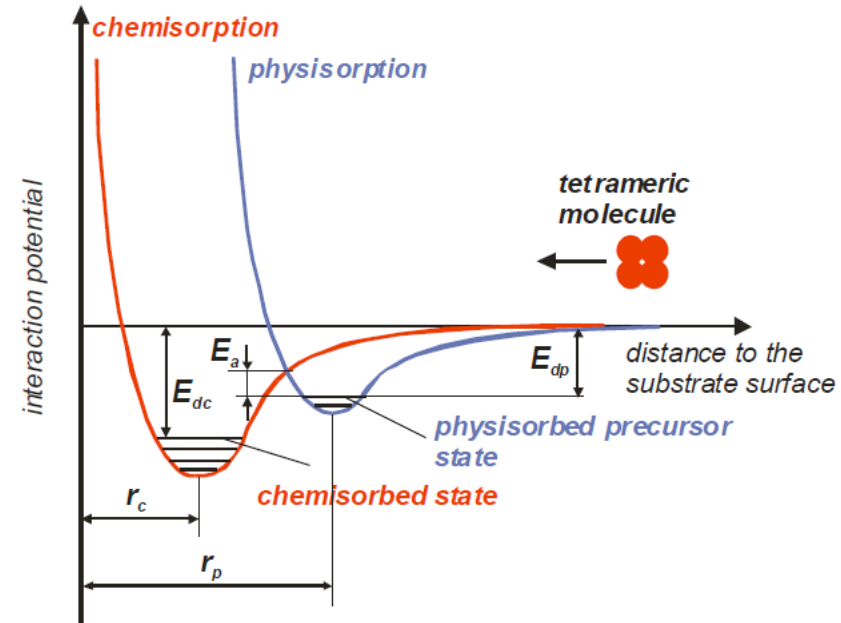
☞ Chemisorption:

strong chemical bond formed.

$$E_a \sim \text{a few eV/atom}$$

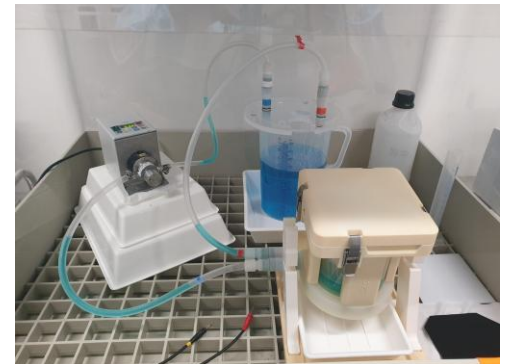
(> substrate sublimation energy)

We will revisit this in PVD



- Pass a current through an aqueous metal solution
 - Anode is made of the metal that you want to deposit
 - Cathode is the conductive seed material on your wafer
 - Positive metal ions travel to the negatively charged cathode on your wafer and deposit there
- Preparing your wafer
 - If you want to plate metal in some places and not in others, you will need a patterned metal seed layer (and typically a 'sticky' metal adhesion layer under that)
 - For very short features, just plate onto the seed layer
 - For taller features, need to plate into a mould
 - Moulds can be photoresist, silicon, SU-8, etc., depending on the needs of your device

Silicet, electroplating system for Cu
Image from CMI



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- MEMS: A balance between academic curiosity and commercial success
- Cleanroom: air, temperature, humidity, media, cloth, tools...
- Thermal oxidation
- CVD: chemical gas-phase reaction + deposition
- Diffusion vs. surface reaction
- Arrhenius plot of the film growth rate



- Tomorrow (Thu / 2 Oct):
 - MOOC self-study, lecture room is available, MOOC: **CVD**

- Next week:
- Wed / 8 Oct
 - SLT_#2 in groups, Topic: CVD
- Thu / 9 Oct
 - MOOC self-study, lecture room is available, MOOC: **PVD**
- Wed / 15 Oct
- **Lecture**, Topic: CVD recap, PVD, and other deposition techniques





See you next time!